

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 09/980,659 | Applicant(s)/Patent Under Reexamination SAKAMOTO ET AL. | |
| | Examiner John A. Jeffery | Art Unit 3742 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------------|----------------|
| | A | US-4,790,901 | 12-1988 | Kettelhoit et al. | 156/498 |
| | B | US-5,421,943 | 06-1995 | Tam et al. | 156/273.9 |
| | C | US-3,859,159 | 01-1975 | Carter et al. | 156/581 |
| | D | US-3,569,665 | 03-1971 | Hager, Jr., Nathaniel E. | 219/200 |
| | E | US-4,437,853 | 03-1984 | Metz, Bruce E. | 493/302 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.